Serial No. <u>10/670,824</u> Applicant: <u>Brokenshire</u>

LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

Applicant: Brokenshire Filing Date: 9/25/2003

Group:

Atty. Docket No. <u>AUS920030702US1</u>

			U.S. PATENT	DOCUMENTS		
Examiner <u>Initial</u>		Document Number	<u>Date</u>	<u>Name</u>	Classification Class / Subclass	Filing Date i
	AA				,	
	AB					
	AC					
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			FOREIGN PATE	NT DOCUMENTS		
Examiner		Document	D-4-	0	01151	Translation
<u>Initial</u> PN	AH	Number JP2002-366534	<u>Date</u> 12-2002	Country	Classification	Yes No
PN	An AI	JP05-242057		Japan	G06F 15/177	abstract only
PN	AI AJ	JP03-242037 JP10-269165	09-1993 10-1998	Japan	G06F 15/16	abstract only
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PN	AK AL	JP08-095757	04-1996	Japan	G06F 9/06	abstract only
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PN	AN	JP08-147171	06-1996	Japan	G06F 9/445	abstract only
PN	AO	ЈР06-044110	02-1994	Japan	G06F 12/00	abstract only

Examiner: /Phillip Nguyen/ Date Considered: 02/09/2007

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<u>Initial</u>

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Applicant: Brokenshire, et. al.

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**STATEMENT** 

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PN	AB	5,548,798	08-1996	King	710/68	•	
	AC						
	AD						

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Examiner Initial

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**Date** 

Country

Classification

Translation Yes No

Examiner Initial OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner:

/Phillip Nguyen/

Date Considered:

02/09/2007

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**STATEMENT** 

Atty. Docket No. AUS920030702US1

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Examiner <u>Initial</u>			<u>Date</u>	<u>Name</u>	Classification Class / Subclass	Filing Date if Appropriate
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## **FOREIGN PATENT DOCUMENTS**

Examiner <u>Initial</u>

Document Number

**Date** 

Country

Classification

Translation Yes No

Examiner <u>Initial</u>

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

Examiner:

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Date Considered:

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STATEMENT

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Atty. Docket No. AUS920030702US1

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PN	AA	5,887,186	03-1999	Nakanishi	712/28		
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**FOREIGN PATENT DOCUMENTS** 

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Classification

Translation Yes No

Examiner Initial OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

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applicant.

In Place of FORM PTO-1449 (Modified) Serial No. 10/670,824 Applicant: Brokenshire, et. al. LIST OF PATENTS AND PUBLICATIONS FOR Filing Date: 9/25/2003 Group: APPLICANT'S INFORMATION DISCLOSURE STATEMENT Atty. Docket No. AUS920030702US1 U. S. PATENT DOCUMENTS Examiner Document Classification Filing Date if <u>Initial</u> Number Date Name Class / Subclass **Appropriate** PN AA 6,526,491 02-2003 Suzuoki et al. 711 / 164 PN AB 6,128,724 10-2000 Lee et al. 712/32 PN AC 6,381,659 04-2002 Proch et al. 710/57 AD AB AF AG AH AI AJ AK AL **FOREIGN PATENT DOCUMENTS** Translation Examiner Document <u>Initial</u> Number Classification Yes No <u>Date</u> Country AM AN AO AP OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) Examiner <u>Initial</u> AQ AR AS AT ΑU 02/09/2007 Date Considered: Examiner: /Phillip Nguyen/ EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to

In Place of	FORM	PTO-1449 (Modif	ied)	Serial No.			•		
In Place of FORM PTO-1449 (Modified)  LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT				Applicant: Brokenshire, et. al.					
				Filing Date:					
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PN	AA	2003/0055984	Jul. 18, 2002	Shimakawa et al.	709	316	Appropriate Oct. 12, 2001		
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PN	AF	2002/0135582	Sep 26, 2002	Suzuoki et al.	345	502	Mar 22, 2001		
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Examiner		Document					Translation		
<u>Initial</u>		Number	<u>Date</u>	Country	<u>Class</u>	<u>Subclass</u>	Yes No		
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